1. Record Nr. UNINA9910146108203321 Autore Iordache Octavian Titolo Evolvable designs of experiments [[electronic resource]]: applications for circuits / / Octavian Iordache Weinheim, : Wiley-VCH, c2009 Pubbl/distr/stampa **ISBN** 1-282-02196-6 9786612021961 3-527-62402-3 3-527-62403-1 Descrizione fisica 1 online resource (232 p.) Disciplina 621.3192 Soggetti Chemical engineering - Mathematical models Experimental design Printed circuits - Design and construction Electronic books. Lingua di pubblicazione Inglese **Formato** Materiale a stampa Livello bibliografico Monografia Note generali Description based upon print version of record. Nota di bibliografia Includes bibliographical references (p. 205-210) and index. Nota di contenuto Evolvable Designs of Experiments: Applications for Circuits; Contents; Preface: Abbreviations: Part One Introduction: 1 Printed Circuits: 1.1 Technology Presentation: 1.2 Inner-Layer Processing: 1.3 Materials Preparation; 1.4 Lamination; 1.5 Drilling; 1.6 Making the Hole Conductive: 1.7 Imaging: 1.8 Electroplating: 1.9 Copper Etching: 1.10 Solder Masking; 1.11 Surface Finishing; 1.12 Routing; 1.13 Testing and Inspection; 1.14 Assembling; 2 Problem Solving for Reliability and Quality: 2.1 Conventional Paradigms: 2.2 Complexity and Time Frames: 2.3 Quasilinearity, Circularity, and Closure 2.4 Advance of Reliability ParadigmsPart Two Evolvable Designs of Experiments (EDOE): 3 Polystochastic Models: 3.1 What Is PSM?: 3.2 Basic Notions for Categorical Frame: 3.3 Illustrative Examples of PSM and Categorical Frames; 3.3.1 Lumped Stochastic Chains; 3.3.2 Conditional Stochastic Chains: 4 First-Order Wave Equation: 4.1 Algebraic Frames for Time"T"and Space"Z"; 4.2 The First-Order Wave

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Sommario/riassunto

Adopting a groundbreaking approach, the highly regarded author shows how to design methods for planning increasingly complex experiments. He begins with a brief introduction to standard quality methods and the technology in standard electric circuits. The book then gives numerous examples of how to apply the proposed methodology in a series of real-life case studies. Although these case studies are taken from the printed circuit board industry, the methods are equally applicable to other fields of engineering.